

#### 20V COMPLEMENTARY PAIR ENHANCEMENT MODE MOSFET

### **Product Summary**

Device	V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> max	I <sub>D</sub> max T <sub>A</sub> = 25°C (Notes 4)
01	20V	0.4Ω @ V <sub>GS</sub> = 4.5V	1.34 A
Q1	200	0.5Ω @ V <sub>GS</sub> = 2.5V	1.65 A
Q2	0.7Ω @ V <sub>GS</sub> = -		-1.14 A
	-20V	0.9Ω @ V <sub>GS</sub> = -2.5V	-0.94 A

#### **Mechanical Data**

- Case: SOT26
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish Matte Tin annealed over Copper leadframe. Solderable per MIL-STD-202, Method 208
- Weight: 0.015 grams (approximate)

#### **Features and Benefits**

- Low On-Resistance
- Low Gate Threshold Voltage V<sub>GS(th)</sub> < 1V
- Low Input Capacitance
- Fast Switching Speed
- Low Input/Output Leakage
- Complementary Pair MOSFET
- Ultra-Small Surface Mount Package
- ESD Protected Gate to 2.5kV HBM
- Lead Free/RoHS Compliant (Note 1)
- "Green" Device (Note 2)
- Qualified to AEC-Q101 Standards for High Reliability

### **Description and Applications**

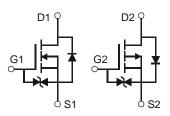
This MOSFET has been designed to minimize the on-state resistance (R<sub>DS(on)</sub>) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Portable electronics

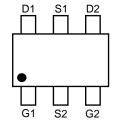


SOT26

Top View



Device symbol



Top view Pin-Out

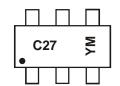
### Ordering Information (Note 3)

Product	Marking	Reel size (inches)	Tape width (mm)	Quantity per reel
DMC2700UDM-7	C27	7	8	3,000

Notes:

- 1. No purposefully added lead.
- 2. Diodes Inc.'s "Green" policy can be found on our website at http://www.diodes.com 3. For packaging details, go to our website at http://www.diodes.com

### **Marking Information**



C27 = Product Type Marking Code YM = Date Code Marking Y = Year (ex: W = 2009)M = Month (ex: 9 = September)

Date Code Key

Year	2009	9	2010		2011	20	12	2013		2014	2	2015
Code	W		X		Υ	2	7	Α		В		С
Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	0	N	D

## Maximum Ratings N-CHANNEL — Q₁ @TA = 25℃ unless otherwise specified

Characteris	Symbol	Value	Unit	
Drain Source Voltage	$V_{DSS}$	20	V	
Gate-Source Voltage	$V_{GSS}$	±6	V	
Drain Current (Note 4)	T <sub>A</sub> = 25℃ T <sub>A</sub> = 85℃	I <sub>D</sub>	1.34 0.97	A

# **Maximum Ratings P-CHANNEL – Q\_2** @T<sub>A</sub> = 25 $^{\circ}$ C unless otherwise specified

Characterist	Symbol	Value	Unit	
Drain Source Voltage	$V_{DSS}$	-20	V	
Gate-Source Voltage		V <sub>GSS</sub>	±6	V
Drain Current (Note 4)	T <sub>A</sub> = 25℃ T <sub>A</sub> = 85℃	I <sub>D</sub>	-1.14 -1.07	А

# Thermal Characteristics @T<sub>A</sub> = 25℃ unless otherwise specified

Characteristic	Symbol	Value	Unit
Power Dissipation (Note 4)	$P_{D}$	1.12	W
Thermal Resistance, Junction to Ambient (Note 4)	$R_{ hetaJA}$	111	°C/W
Operating and Storage Temperature Range	$T_J$ , $T_{STG}$	-55 to +150	°C

Notes: 4. For a device mounted on 25mm X 25mm FR-4 PCB board with a high coverage of single sided 1oz copper, in still air conditions with two active die

# Electrical Characteristics N-CHANNEL - Q₁ @TA = 25℃ unless otherwise specified

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 5)							
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	20	_	_	V	$V_{GS} = 0V, I_D = 250\mu A$	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	_	_	100	nA	$V_{DS} = 20V, V_{GS} = 0V$	
Gate-Source Leakage	I <sub>GSS</sub>	_	_	± 1.0	μΑ	$V_{GS} = \pm 4.5V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V <sub>GS(th)</sub>	0.5	_	1.0	V	$V_{DS} = V_{GS}$ , $I_D = 250 \mu A$	
		_	0.3	0.4		$V_{GS} = 4.5V, I_D = 600mA$	
Static Drain-Source On-Resistance	R <sub>DS</sub> (ON)	_	0.4	0.5	Ω	$V_{GS} = 2.5V, I_D = 500mA$	
		_	0.5	0.7		$V_{GS} = 1.8V, I_D = 350mA$	
Forward Transfer Admittance	Y <sub>fs</sub>	_	1.4	_	S	$V_{DS} = 10V, I_{D} = 400 \text{mA}$	
Diode Forward Voltage (Note 5)	$V_{SD}$	_	0.7	1.2	V	$V_{GS} = 0V, I_{S} = 150mA$	
DYNAMIC CHARACTERISTICS							
Input Capacitance	C <sub>iss</sub>	_	60.67	_	pF	1/ 10// 1/ 01/	
Output Capacitance	Coss	_	9.68	_	pF	$V_{DS} = 16V, V_{GS} = 0V$ - f = 1.0MHz	
Reverse Transfer Capacitance	C <sub>rss</sub>	_	5.37	_	pF	T = 1.0IVII IZ	
Total Gate Charge	Qg	_	736.6	_		\\ 4.5\\\\ 10\\\	
Gate-Source Charge	$Q_{gs}$	_	93.6	_	рC	$V_{GS} = 4.5V, V_{DS} = 10V,$ $I_{D} = 250 \text{mA}$	
Gate-Drain Charge	$Q_{gd}$	_	116.6			ID = 250IIIA	
Turn-On Delay Time	t <sub>d(on)</sub>	_	5.1	_		\\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	
Turn-On Rise Time	t <sub>r</sub>	_	7.4	_	ns	$V_{DD} = 10V, V_{GS} = 4.5V,$ $R_{L} = 47\Omega, R_{G} = 10\Omega,$	
Turn-Off Delay Time	t <sub>d(off)</sub>	_	26.7	_	115	$R_L = 4752$ , $R_G = 1052$ , $I_D = 200 \text{mA}$	
Turn-Off Fall Time	t <sub>f</sub>		12.3			ID = ZUUMA	

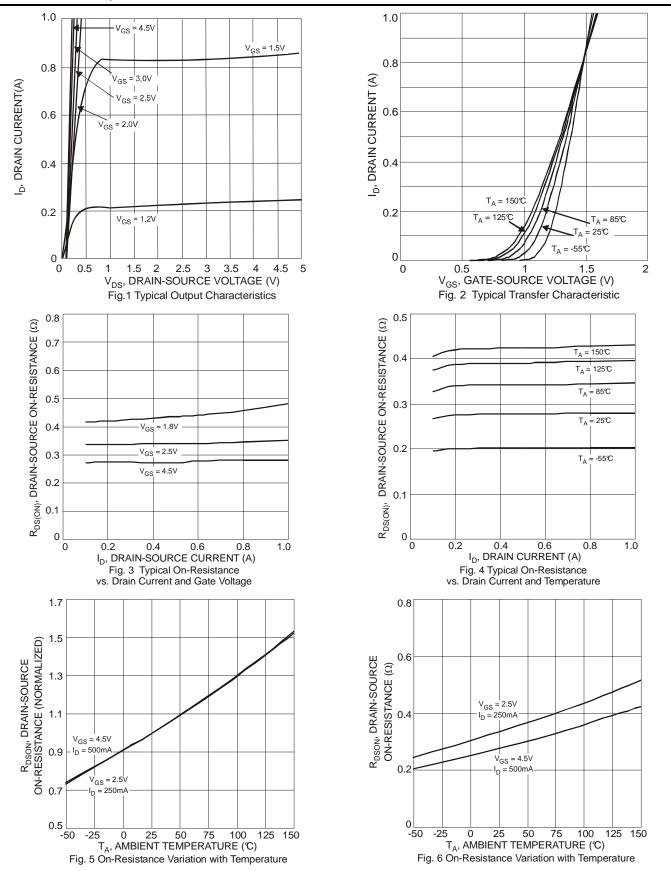
## Electrical Characteristics P-CHANNEL - Q₂ @TA = 25℃ unless otherwise specified

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 5)						•	
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	-20	_	_	V	$V_{GS} = 0V, I_D = -250\mu A$	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	_		-100	nA	$V_{DS} = -20V, V_{GS} = 0V$	
Gate-Source Leakage	I <sub>GSS</sub>	_	_	± 1.0	μΑ	$V_{GS} = \pm 4.5V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 5)			_		_		
Gate Threshold Voltage	V <sub>GS(th)</sub>	-0.5	_	-1.0	V	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	
			0.5	0.7		$V_{GS} = -4.5V$ , $I_D = -430mA$	
Static Drain-Source On-Resistance	R <sub>DS (ON)</sub>	_	0.7	0.9	Ω	$V_{GS} = -2.5V, I_D = -300mA$	
			1.0	1.3		$V_{GS} = -1.8V, I_D = -150mA$	
Forward Transfer Admittance	Y <sub>fs</sub>	_	-0.9	_	S	$V_{DS} = 10V, I_{D} = -250mA$	
Diode Forward Voltage (Note 5)	$V_{SD}$	_	-0.8	-1.2	V	$V_{GS} = 0V, I_{S} = -150mA$	
DYNAMIC CHARACTERISTICS							
Input Capacitance	C <sub>iss</sub>	_	59.76	_	pF	101/11/	
Output Capacitance	Coss	_	12.07	_	pF	$V_{DS} = -16V, V_{GS} = 0V$ - f = 1.0MHz	
Reverse Transfer Capacitance	C <sub>rss</sub>	_	6.36	_	pF	T = 1.0MH2	
Total Gate Charge	Qq	_	622.4	_		151/1/ 101/	
Gate-Source Charge	Qgs	_	100.3	_	рC	$V_{GS} = -4.5V, V_{DS} = -10V,$	
Gate-Drain Charge	Q <sub>gd</sub>	_	132.2	_		$I_D = -250 \text{mA}$	
Turn-On Delay Time	t <sub>d(on)</sub>	_	5.1	_			
Turn-On Rise Time	t <sub>r</sub>	_	8.1	_	1	$V_{DD} = -10V, V_{GS} = -4.5V,$	
Turn-Off Delay Time	t <sub>d(off)</sub>	_	28.4	_	ns	$R_L = 47\Omega$ , $R_G = 10\Omega$ ,	
Turn-Off Fall Time	t <sub>f</sub>	_	20.7	_	1	$I_D = -200 \text{mA}$	

Notes: 5. Short duration pulse test used to minimize self-heating effect.



### N-CHANNEL - Q1





## N-CHANNEL - Q<sub>1</sub> (continued)

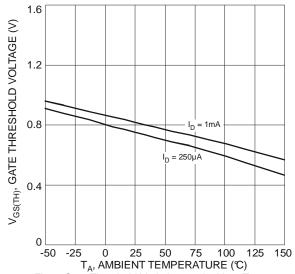
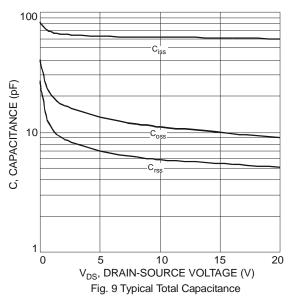
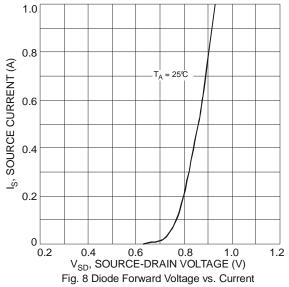


Fig. 7 Gate Threshold Variation vs. Ambient Temperature





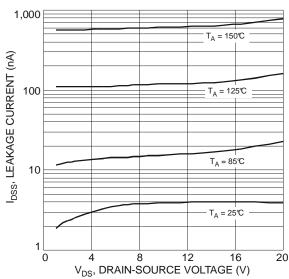


Fig. 10 Typical Leakage Current vs. Drain-Source Voltage



#### P-CHANNEL - Q<sub>2</sub>

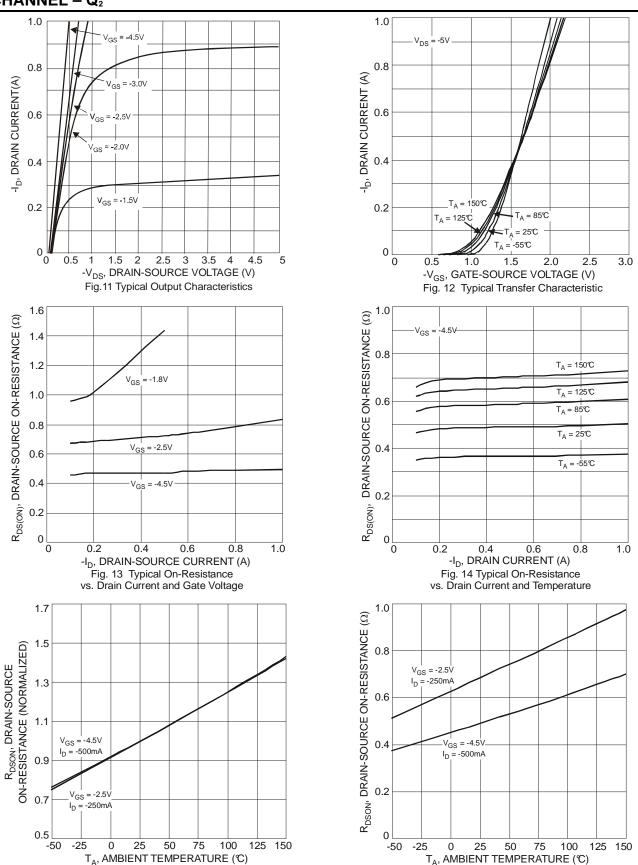


Fig. 15 On-Resistance Variation with Temperature

 $T_A$ , AMBIENT TEMPERATURE (°C)

Fig. 16 On-Resistance Variation with Temperature



# P-CHANNEL - Q<sub>2</sub> (continued)

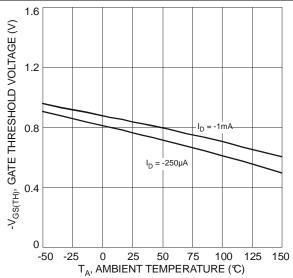
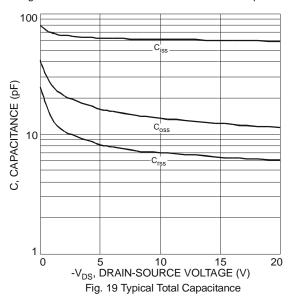
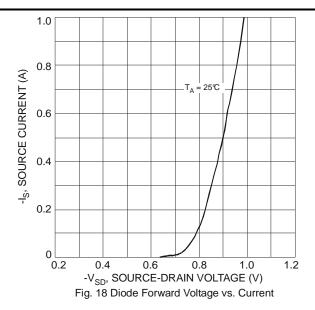
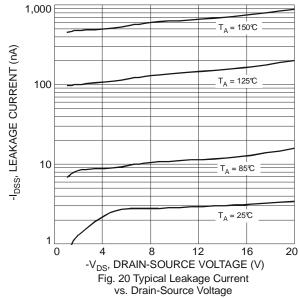


Fig. 17 Gate Threshold Variation vs. Ambient Temperature

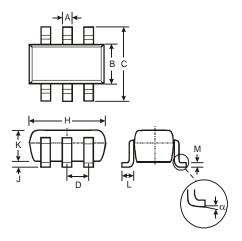






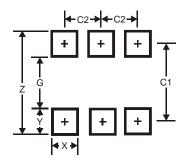


# **Package Outline Dimensions**



	SOT26					
Dim	Min	Max	Тур			
Α	0.35	0.50	0.38			
В	1.50	1.70	1.60			
С	2.70	3.00	2.80			
D	_	_	0.95			
Н	2.90	3.10	3.00			
J	0.013	0.10	0.05			
K	1.00	1.30	1.10			
L	0.35	0.55	0.40			
М	0.10	0.20	0.15			
α	0°	8°	_			
All D	All Dimensions in mm					

# **Suggested Pad Layout**



Dimensions	Value (in mm)
Z	3.20
G	1.60
Х	0.55
Y	0.80
C1	2.40
C2	0.95



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